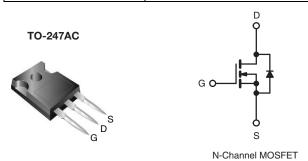


Vishay Siliconix

### Power MOSFET

PRODUCT SUMMARY						
V <sub>DS</sub> (V)	600					
R <sub>DS(on)</sub> (Ω)	V <sub>GS</sub> = 10 V 0.60					
Q <sub>g</sub> (Max.) (nC)	84					
Q <sub>gs</sub> (nC)	18					
Q <sub>gd</sub> (nC)	36					
Configuration	Single					



#### **FEATURES**

- Ultra Low Gate Charge
- Reduced Gate Drive Requirement
- Enhanced 30 V V<sub>GS</sub> Rating
- Reduced C<sub>iss</sub>, C<sub>oss</sub>, C<sub>rss</sub>
- Isolated Central Mounting Hole
- Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- Compliant to RoHS Directive 2002/95/EC

#### DESCRIPTION

This new series of low charge Power MOSFETs achieve significantly lower gate charge over conventional MOSFETs. Utilizing advanced Power MOSFET technology the device improvements allow for reduced gate drive requirements, faster switching speeds and increased total system savings. These device improvements combined with the proven ruggedness and reliability of Power MOSFETs offer the designer a new standard in power transistors for switching applications.

TO-247AC The package preferred commercial-industrial applications where higher power levels preclude the use of TO-220AB devices. The TO-247AC is similar but superior to the earlier TO-218 package because its isolated mounting hole.

ORDERING INFORMATION			
Package	TO-247AC		
Lead (Pb)-free	IRFPC50LCPbF		
Lead (i b)-life	SiHFPC50LC-E3		
SnPb	IRFPC50LC		
Sill b	SiHFPC50LC		

PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			$V_{DS}$	600	V	
Gate-Source Voltage			$V_{GS}$	± 30	V	
Continuous Drain Current	V <sub>GS</sub> at 10 V	$V = T_{C} = 25 ^{\circ}C$ $T_{C} = 100 ^{\circ}C$	I <sub>D</sub>	11	А	
Continuous Brain Current	VGS at 10 V			7.3		
Pulsed Drain Current <sup>a</sup>			I <sub>DM</sub>	44		
Linear Derating Factor				1.5	W/°C	
Single Pulse Avalanche Energy <sup>b</sup>			E <sub>AS</sub>	920	mJ	
Repetitive Avalanche Currenta			I <sub>AR</sub>	11	Α	
Repetitive Avalanche Energy <sup>a</sup>			E <sub>AR</sub>	19	mJ	
Maximum Power Dissipation $T_C = 25 ^{\circ}C$			$P_{D}$	190	W	
Peak Diode Recovery dV/dt <sup>c</sup>			dV/dt	3.0	V/ns	
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	- 55 to + 150	°C	
Soldering Recommendations (Peak Temperature)	for 10	) s		300 <sup>d</sup>	1	
Mounting Torque	6 32 or M3	6-32 or M3 screw		10	lbf ⋅ in	
Mounting Torque	0-32 of M3 Screw			1.1	N⋅m	

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b.  $V_{DD}$  = 25 V, starting  $T_J$  = 25 °C, L = 13 mH,  $R_g$  = 25  $\Omega$ ,  $I_{AS}$  = 11 Å (see fig. 12). c.  $I_{SD} \le$  11 Å,  $dI/dt \le$  100 Å/ $\mu$ s,  $V_{DD} \le$   $V_{DS}$ ,  $T_J \le$  150 °C. d. 1.6 mm from case.

<sup>\*</sup> Pb containing terminations are not RoHS compliant, exemptions may apply

# IRFPC50LC, SiHFPC50LC

# Vishay Siliconix



THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient	R <sub>thJA</sub>	-	40		
Case-to-Sink, Flat, Greased Surface	R <sub>thCS</sub>	0.24	-	°C/W	
Maximum Junction-to-Case (Drain)	R <sub>thJC</sub>	-	0.65		

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static							
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0$	V, I <sub>D</sub> = 250 μA	600	-	-	V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference t	to 25 °C, I <sub>D</sub> = 1 mA	-	0.59	-	V/°C
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V$	<sub>GS</sub> , I <sub>D</sub> = 250 μA	2.0	-	4.0	V
Gate-Source Leakage	I <sub>GSS</sub>	V <sub>G</sub>	<sub>S</sub> = ± 20 V	-	-	± 100	nA
Zana Oata Valtana Duain Ourmant		V <sub>DS</sub> = 60	V <sub>DS</sub> = 600 V, V <sub>GS</sub> = 0 V		-	25	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 480 V, V	/ <sub>GS</sub> = 0 V, T <sub>J</sub> = 125 °C	-	-	250	μA
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 6.6 A <sup>b</sup>	-	-	0.60	Ω
Forward Transconductance	9 <sub>fs</sub>	V <sub>DS</sub> = 10	00 V, I <sub>D</sub> = 6.6 A <sup>b</sup>	7.0	-	-	S
Dynamic							
Input Capacitance	C <sub>iss</sub>	V	V <sub>GS</sub> = 0 V,		2300	-	
Output Capacitance	C <sub>oss</sub>	V	os = 25 V,	-	270	-	pF
Reverse Transfer Capacitance	C <sub>rss</sub>	f = 1.0 l	MHz, see fig. 5	-	28	-	
Total Gate Charge	Qg		V <sub>GS</sub> = 10 V		-	84	nC
Gate-Source Charge	$Q_{gs}$	V <sub>GS</sub> = 10 V			-	18	
Gate-Drain Charge	Q <sub>gd</sub>		l see light called to	-	-	36	
Turn-On Delay Time	t <sub>d(on)</sub>	$V_{DD} = 300 \text{ V, } I_D = 11 \text{ A ,}$ $R_g = 6.2 \ \Omega, \ R_D = 30 \ \Omega, \ \text{see fig. } 10^b$		-	17	-	ns
Rise Time	t <sub>r</sub>			-	32	-	
Turn-Off Delay Time	t <sub>d(off)</sub>			-	41	-	
Fall Time	t <sub>f</sub>			-	26	-	
Internal Drain Inductance	L <sub>D</sub>	Between lead, 6 mm (0.25") from package and center of die contact		-	5.0	-	
Internal Source Inductance	L <sub>S</sub>			-	13	-	- nH
Drain-Source Body Diode Characteristic	s				·		
Continuous Source-Drain Diode Current	I <sub>S</sub>	MOSFET symbol showing the integral reverse p - n junction diode		ı	-	11	A
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>			I	-	44	
Body Diode Voltage	$V_{SD}$	T <sub>J</sub> = 25 °C, I <sub>S</sub> = 11 A, V <sub>GS</sub> = 0 V <sup>b</sup>		-	-	1.4	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>	T 25 °C 1	11 A dl/dt = 100 A/uch	ı	590	890	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	$T_J = 25  ^{\circ}\text{C}, I_F = 11  \text{A, dl/dt} = 100  \text{A/}\mu\text{s}^b$		-	4.5	6.8	μC
Forward Turn-On Time	t <sub>on</sub>	Intrinsic turn-	ırn-on is dominated by L <sub>S</sub> and L <sub>D</sub> )			L <sub>D</sub> )	

#### Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width  $\leq$  300  $\mu$ s; duty cycle  $\leq$  2 %.



### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

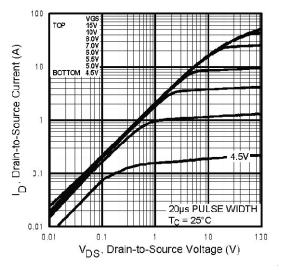


Fig. 1 - Typical Output Characteristics, T<sub>C</sub> = 25 °C

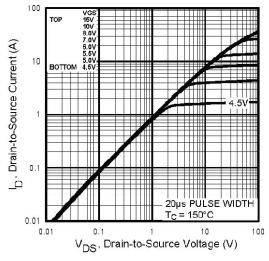


Fig. 2 - Typical Output Characteristics, T<sub>C</sub> = 150 °C

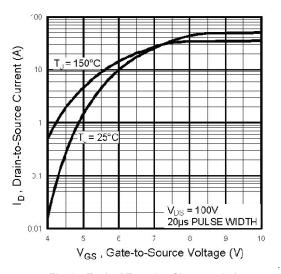


Fig. 3 - Typical Transfer Characteristics

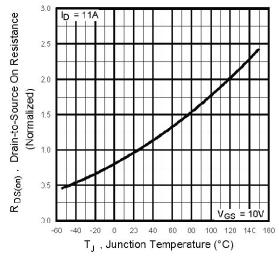


Fig. 4 - Normalized On-Resistance vs. Temperature

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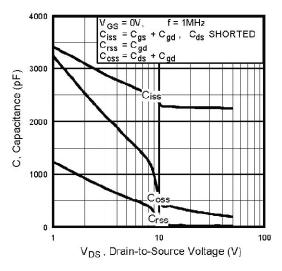


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

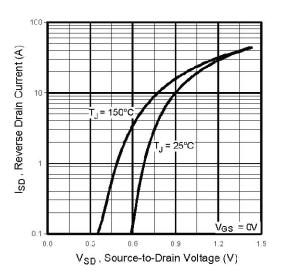


Fig. 7 - Typical Source-Drain Diode Forward Voltage

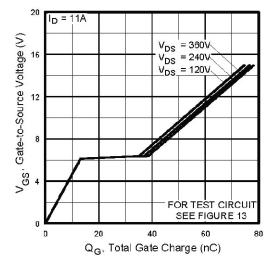


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

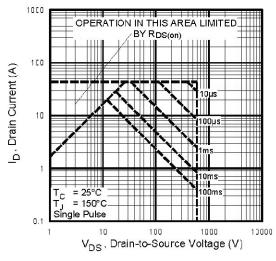


Fig. 8 - Maximum Safe Operating Area



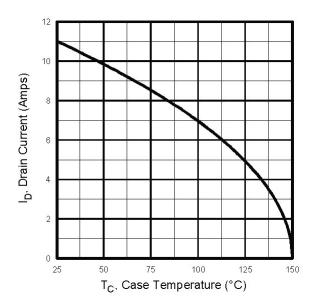


Fig. 9 - Maximum Drain Current vs. Case Temperature

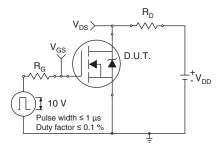


Fig. 10a - Switching Time Test Circuit

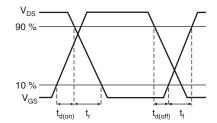


Fig. 10b - Switching Time Waveforms

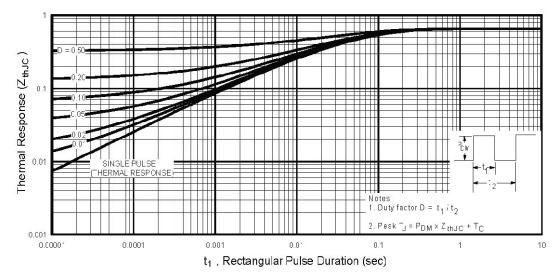
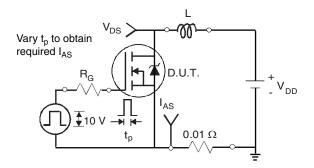


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

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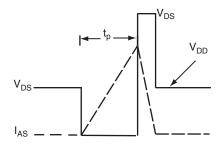


Fig. 12a - Unclamped Inductive Test Circuit

Fig. 12b - Unclamped Inductive Waveforms

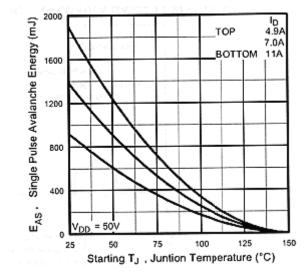


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

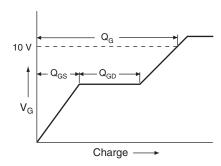


Fig. 13a - Basic Gate Charge Waveform

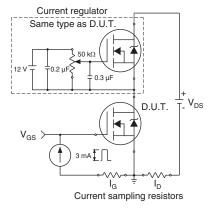
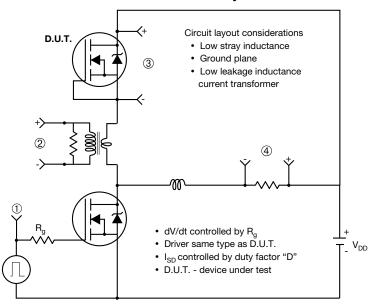


Fig. 13b - Gate Charge Test Circuit



#### Peak Diode Recovery dV/dt Test Circuit



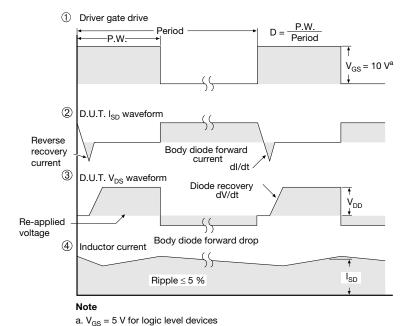
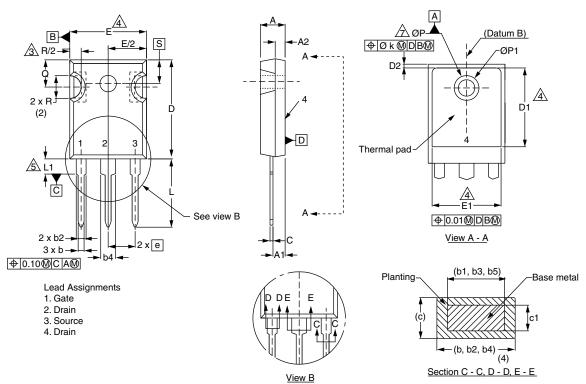


Fig. 14 - For N-Channel

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# **TO-247AC (High Voltage)**



	MILLIMETERS		MILLIMETERS		INC	HES
DIM.	MIN.	MAX.	MIN.	MAX.		
Α	4.58	5.31	0.180	0.209		
A1	2.21	2.59	0.087	0.102		
A2	1.17	2.49	0.046	0.098		
b	0.99	1.40	0.039	0.055		
b1	0.99	1.35	0.039	0.053		
b2	1.53	2.39	0.060	0.094		
b3	1.65	2.37	0.065	0.093		
b4	2.42	3.43	0.095	0.135		
b5	2.59	3.38	0.102	0.133		
С	0.38	0.86	0.015	0.034		
c1	0.38	0.76	0.015	0.030		
D	19.71	20.82	0.776	0.820		
D1	13.08	-	0.515	-		

	MILLIMETERS		INC	HES	
DIM.	MIN.	MAX.	MIN.	MAX.	
D2	0.51	1.30	0.020	0.051	
E	15.29	15.87	0.602	0.625	
E1	13.72	ı	0.540	ı	
е	5.46	BSC	0.215 BSC		
Øk	0.2	0.254		0.010	
L	14.20	16.25	0.559	0.640	
L1	3.71	4.29	0.146	0.169	
N	7.62 BSC		0.300 BSC		
ØΡ	3.51	3.66	0.138	0.144	
Ø P1	-	7.39	-	0.291	
Q	5.31	5.69	0.209	0.224	
R	4.52	5.49	0.178	0.216	
S	5.51 BSC		0.217 BSC		
0.01200					

ECN: X13-0103-Rev. D, 01-Jul-13

DWG: 5971

#### **Notes**

- 1. Dimensioning and tolerancing per ASME Y14.5M-1994.
- 2. Contour of slot optional.
- 3. Dimension D and E do not include mold flash. Mold flash shall not exceed 0.127 mm (0.005") per side. These dimensions are measured at the outermost extremes of the plastic body.
- 4. Thermal pad contour optional with dimensions D1 and E1.
  5. Lead finish uncontrolled in L1.
- 6. Ø P to have a maximum draft angle of 1.5 to the top of the part with a maximum hole diameter of 3.91 mm (0.154").
- 7. Outline conforms to JEDEC outline TO-247 with exception of dimension c.
- 8. Xian and Mingxin actually photo.





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